

Notice of References Cited	Application/Control No. 10/501,960	Applicant(s)/Patent Under Reexamination UENISHI ET AL.	
	Examiner Lisa N. Klaus	Art Unit 2832	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-5,451,272	09-1995	Uemura et al.	148/431
*	D	US-4,695,330	09-1987	Shibata, Akira	148/281
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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